IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Zhigiang Wu, et al. Docket No: TI-29922.1

Serial No: Not Assigned Conf. No: Not Assigned

Examiner: TBD Art Unit: TBD

Filed: 07/17/2003

For: TRANSISTOR CIRCUIT WITH VARYING RESISTANCE LIGHTLY DOPED DIFFUSED

REGIONS FOR ELECTROSTATIC DISCHARGE ("ESD") PROTECTION

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97 & 1.98

Commissioner For Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

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Applicants wish to bring to the attention of the Patent and Trademark Office the information noted on the enclosed PTO/SB/08A. A copy of the noted references were provided in connection with the parent application and are therefore not being supplied herewith.

Please charge any shortage in the fees due in connection with the filing of this paper, including extension of time fees, to the deposit account of Texas Instruments Incorporated, Account No. 20-0668, and please credit any excess fees to such Deposit Account. Any further necessary extension of time is hereby requested.

Respectfully submitted,

Peter K. McLarty Attorney for Applicants Reg. No. 44,923

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1	Substitute for Form 1449A/PTO				Complete If Known			
١					Application Number			
I		INFORMATIO	N DISCLOSURE		Filing Date	07/17/2003		
İ			BY APPLICANT		First Named Inventor	Zhiqiang Wu, et al.		
l		STATEMENT	DI APPLICANI		Group Art Unit			
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Ì	Sheet	1	of	1	Attorney Docket No.	TI-29922.1		

				U.	S. PATENT DOC	JMENTS
U.S. Patent		t Document	Name of Patentee	Date of Pub.		
Exam. Initials*	Cite No.1	Number	Kind Code ² (if known)	or Applicant of Cited Doc.	of Cited Doc. (mm-dd-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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	CG						
	СН						

Examiner	Date	1
Signature	Considered	

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw tine through citation if not in conformance and not considered, include copy of this form with next communication to applicant.

¹Unique citation designation number. ²Applicant is to place a check mark here if English Translation is attached.